Analysis of the Nonequilibrium Heat Transport Time of Electrons in Cu Films Irradiated by a Femtosecond Laser Beam

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The finite element method (FEM) is used to simulate the changes of electron temperature and lattice temperature in Cu films during the femtosecond laser pulses heating. The simulation results show that during the electron nonequilibrium relaxation time, the full width at half maximum (FWHM) time of the electron temperature will rise with the increase of the pulse number, the width and pulses interval; however, the electron nonequilibrium relaxation time is independent of both the pulses interval and pulse width, but increased with the number of excitation pulses. By the laser heating with the four pulses of 300 fs, and the pulses interval of 520 fs, the FWHM time of electron temperature is 5.6 ps, and the electron nonequilibrium relaxation time is 15 ps. Compared with the single pulse heating that the FWHM time of electron temperature is 1 ps, and the electron nonequilibrium relaxation time is 8 ps, they have been significantly improved.

Keywords: Femtosecond laser, copper, Cu, films, electron temperature, lattice temperature, electron nonequilibrium relaxation

1 INTRODUCTION

The main application of femtosecond laser in industry is femtosecond laser processing [1], such as femtosecond laser cutting [2, 3], femtosec-
ond laser drilling [4, 5]. The outstanding advantage is that there is almost no heat affected areas during femtosecond laser processing [6, 7]. This process, however, only occurs in the nonequilibrium conduction duration of the electronic temperature. Here, the heat which is produced by the laser heating is diffused faster in the air than diffused into the crystal lattices, the lattice temperature remains low, so there is almost no thermal effect.

The ablation of the metal film by femtosecond laser pulse is a nonequilibrium thermal process and the process duration is extremely short - less than several picoseconds, so a single femtosecond pulse cannot make the laser processing efficiently. So, in actual industrial processing, people are usually using femtosecond laser pulses with high repetition frequency. In such instances the pulse interval of the femtosecond laser is much greater than the electron photon relaxation time; consequently, the electron and lattice temperature can be approximated in the state of thermal equilibrium because at this condition, the action of the laser beam heating metal films is similar to the process of equilibrium thermal conduction. With the increase of the number of pulses, the thermal effect is more serious: both the stress, the crack and the roughness of the ablated edge are increased and so the processing effect is worse [8, 9].

In order to solve the problem of the short electron nonequilibrium relaxation time, a number of femtosecond laser pulses with a certain time interval are used. By designing the femtosecond laser pulses sequence, it can significantly extend the electron nonequilibrium relaxation time, so the thermal effect in the laser heating process will be effectively suppressed, and the quality and efficiency in industrial processing will be improved.

2 THEORETICAL ANALYSIS AND CALCULATION

When the femtosecond laser heat the metal films, the electron temperature rises sharply and transfer through thermal diffusion. The nonequilibrium state of the electron temperature and lattice temperature in thermal transfer process is simulated by the double temperature equation [10, 11]:

\[
C_e \frac{\partial T_e}{\partial t} - \frac{\partial}{\partial x} \left( k_e \frac{\partial T_e}{\partial x} \right) = S(x,t) - G(T_e - T_l)
\]  

(1)

\[
C_l \frac{\partial T_l}{\partial t} = G(T_e - T_l)
\]

(2)
where $C_e$ is the electron heat capacity, $C_l$ is the lattice heat capacity, $T_e$ is the electron temperature, $T_l$ is the lattice temperature, $k_e$ is the electron thermal conductivity and $G$ is the electron lattice coupling coefficient. Where $C_e$ and $k_e$ in Equation (1) are functions of electron temperature and lattice temperature; the specific expression is

$$C_e = \gamma T_e.$$  

(5)

$$k_e = k_0 \frac{T_e}{T_l}.$$  

(6)

$S(x,t)$ is the heat source under the irradiation of a Gauss laser pulse:

$$S(x,t) = (1-R)J e^{\frac{-(t-t_p)^2}{t_p \alpha}} e^{-\frac{x}{\alpha}}.$$  

(7)

where $R$ is the reflectance of the metal surface, $J$ is the laser energy per unit area, $t_p$ is the duration of the laser pulse, $\alpha$ is the absorption depth of the metal to the laser energy, $\beta$ is the coefficient and the value is $4ln2$.

Under femtosecond laser heating, the electron temperature and lattice temperature distribution in 200 nm Cu film are simulated by finite element method. The physical properties of Cu during the simulation are listed in Table 1.

<table>
<thead>
<tr>
<th>$\gamma$</th>
<th>$k_0$</th>
<th>$R$</th>
<th>$\alpha$</th>
<th>$C_1$</th>
<th>$G$</th>
</tr>
</thead>
<tbody>
<tr>
<td>96.6 J/m$^3$K$^2$</td>
<td>401 W/mK</td>
<td>0.6</td>
<td>14.2 nm</td>
<td>$3.5 \times 10^6$ J/m$^3$K</td>
<td>$1.02 \times 10^6$ W/m$^3$K</td>
</tr>
</tbody>
</table>
3 INTERPRETATION OF RESULTS

As shown in Figure 1, the thickness of the Cu film is 200 nm, the femtosecond laser pulse width is 100 fs and its energy density is 500 J/m². The variation of electron temperature and the lattice temperature in the Cu film surface is detected during the laser pulse heating. It can be seen from the Figure 1 that the electron temperature increased fast after the laser beam interaction and reached at the peak of 11000 K. Thereafter it decreased rapidly, while the lattice temperature increased slightly and remained below 1000 K. The electron nonequilibrium relaxation time \( t_s \) in the Cu film is about 8 ps. In addition, we define the total time interval of the electron temperature from the peak to the half of the peak is full width at half maximum (FWHM) time \( t_m \). When the femtosecond laser beam can cause the Cu film to produce plasma expansion and effectively remove the metal materials, we find that \( t_m \) is very short, about 1 ps, so the processing efficiency of femtosecond laser using single pulse will be not high.

Figure 2 presents the increasing of \( t_s \) and \( t_m \) by changing the laser pulse width. We simulated the distributions of the electron temperature and lattice temperature with the pulse widths of 50, 100, 200, 350 and 500 fs. Under the condition of pulse width of 50 fs, \( t_s \) is 8 ps, \( t_m \) is 1 ps, the peak of electron temperature is 11900 K; and under the condition of pulse width is 500 fs, \( t_s \) is 8 ps and \( t_m \) is 1.5 ps, the peak of electron temperature is 7600 K. It can be clearly seen that: as the pulse width increases, \( t_s \)
remains unchanged at 8 ps and \( t_m \) increases from 1 ps to 1.5 ps. Otherwise, in the condition of the power density of the femtosecond laser remain the same, the electron peak temperature has decreased, inverse to the laser pulse width.

But, \( t_s \) and \( t_m \) cannot be increased continuously by changing the pulse width, because with the pulse width increases, the laser pulse is no longer a femtosecond pulse, and when the pulse width is greater than the electron relaxation time, there will be significant thermal effect, so as follow we will discuss the increasing of the electron nonequilibrium time by applying a plurality of femtosecond pulses.

Figure 3(a) shows the 200 nm Cu film heating by the two pulses with the single femtosecond laser pulse width is 100 fs. The two laser pulses interval time is very short, only 120 fs, so the electron temperature curve appears as a single peak and its shape similar to the Figure 1. The peak electron temperature is 13500 K, \( t_s \) is 10.1 ps and \( t_m \) is 1.7 ps. Then, as the pulses interval increases (the pulses interval is 320 fs), two peaks appear in the electron temperature curve and while \( t_s \) is substantially unchanged, \( t_m \) increases. When the pulses interval is 520 fs, \( t_s \) remains unchanged at 10.1 ps, but \( t_m \) increases to 2.2 ps. Similarly, from Figure 3(b) and Figure 3(c) it can be seen that when the laser pulse width is 200 and 300 fs, respectively, the two pulses interval increase from 120 to 520 fs, respectively; \( t_s \) is basically maintained at 10.1 ps and \( t_m \) increases from 1.7 to 2.6 ps. In comparison with Figures 3(a) to (c), it can be seen that the magnitude of the \( t_s \) is independent of both the pulses interval and the pulse width.
(a)

(b)
width; however, the $t_m$ value is proportional to the single pulse width and the pulses interval.

In order to prolong $t_m$, three and four pulses heating the film are simulated, as shown in Figure 4 and Figure 5. In Figure 4 the Cu film is heated by three femtosecond laser pulses and the pulse width is 100, 200 and 300 fs. The value of $t_s$ is unchanged at 12.7 ps, but $t_m$ increased from 2.7 to 4.1 ps. In Figure 5, using four femtosecond laser pulse heating, and the pulse width is 100, 200 and 300 fs, but $t_s$ is 15 ps and $t_m$ increased from 4.3 to 5.2 ps.

Comparing Figures 3 to 5 we find that $t_s$ increases from 10.1 to 15.0 ps with the increase of the number of pulses. The magnitude of $t_s$ is independent of both pulses interval and pulse width, but proportional to the number of pulses. The value of $t_m$ increases from 2.6 (two pulses heating) to 5.2 ps (four pulses heating) and is greatly improved compared to the 1.0 ps (single pulse heating). We can see then that the value of $t_m$ is relative to the number of pulses, the pulse width, as well as the pulses interval.
We used a finite element method (FEM) model to simulate electron and lattice temperature, and the nonequilibrium relaxation time changes during the process of femtosecond laser pulses heating of 200 nm Cu metal film. We can find that when the pulse width is 100 fs and the single pulse energy density is 500 J/m², the full width at half maximum (FWHM) time of the electron temperature is only about 1.0 ps and the electron nonequilibrium relaxation time is about 8.0 ps. In order to increase the FWHM time and electron nonequilibrium relaxation time we use multiple pulses to excite. The results showed that the FWHM time is proportional to the pulse number, single pulse width and the pulses interval; the electron temperature is independent of the pulses interval and pulse width, but proportional to the number of excitation pulses. Finally, when we use the four femtosecond laser pulses to heat the Cu film with a single pulse width of 300 fs and pulse interval of 520 fs, the FWHM time of electronic temperature is 5.6 ps and the electron nonequilibrium relaxation time is about 15.0 ps. For single pulses the FWHM time of electronic temperature is 1.0 ps and the electron nonequilibrium relaxation time is 8.0 ps. Clearly there has been a significant improvement.

**FIGURE 4**
Graphs showing the electron and lattice temperature curves irradiated by three femtosecond laser pulses with different width and interval: (a) pulse width is 100 fs; (b) pulse width is 200 fs; and (c) pulse width is 300 fs.
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NOMENCLATURE

\( C_e \)  
Electron heat capacity (mJ/molK^2)

\( C_l \)  
Lattice heat capacity (mJ/molK^2)

\( G \)  
Electron lattice coupling coefficient
\( J \)  
Laser energy per unit area (J/m²)

\( k_e \)  
Electron thermal conductivity (W/mK)

\( R \)  
Reflectance of the Cu surface

\( t_p \)  
Duration of the laser pulse (seconds)

\( T_e \)  
Electron temperature (K)

\( T_l \)  
Lattice temperature (K)

**Greek symbols**

\( \alpha \)  
Absorption depth of the laser beam in the Cu (m)

\( \beta \)  
Coefficient

**REFERENCES**


